

DS90CF561, DS90CF562

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LVDS 18-Bit Color Flat Panel Display (FPD) Link

Check for Samples: DS90CF561, DS90CF562

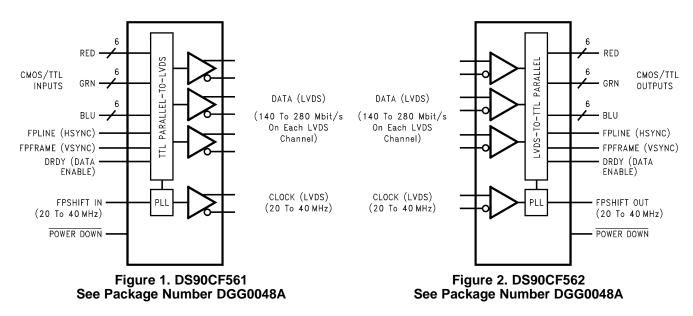
FEATURES

- Up to 105 Megabyte/sec Bandwidth
- Narrow Bus Reduces Cable Size and Cost
- 290 mV Swing LVDS Devices for Low EMI
- Low Power CMOS Design
- Power Down Mode
- PLL Requires No External Components
- Low Profile 48-Lead TSSOP Package
- Falling Edge Data Strobe
- Compatible with TIA/EIA-644 LVDS Standard

DESCRIPTION

The DS90CF561 transmitter converts 21 bits of CMOS/TTL data into three LVDS (Low Voltage Differential Signaling) data streams. A phase-locked transmit clock is transmitted in parallel with the data streams over a fourth LVDS link. Every cycle of the transmit clock 21 bits of input data are sampled and transmitted. The DS90CF562 receiver converts the LVDS data streams back into 21 bits of CMOS/TTL data. At a transmit clock frequency of 40 MHz, 18 bits of RGB data and 3 bits of LCD timing and control data (FPLINE, FPFRAME, DRDY) are transmitted at a rate of 280 Mbps per LVDS data channel. Using a 40 MHz clock, the data throughput is 105 Megabytes per second. These devices are offered with falling edge data strobes for convenient interface with a variety of graphics and LCD panel controllers.

This chipset is an ideal means to solve EMI and cable size problems associated with wide, high speed TTL interfaces.



Block Diagrams

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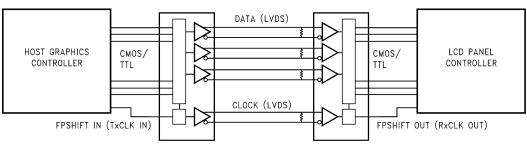
Connection Diagrams

INSTRUMENTS

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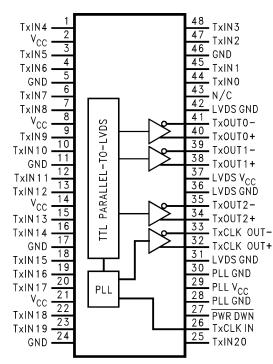
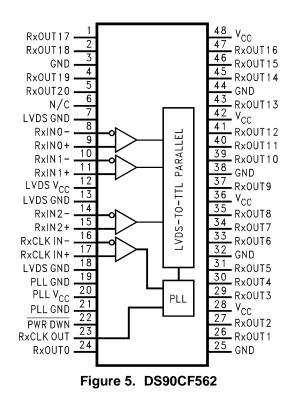


Figure 4. DS90CF561





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Absolute Maximum	n Ratings	(1)(2)(3)
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	Value
Supply Voltage (V _{CC})	-0.3 to +6V
CMOS/TTL Input Voltage	-0.3 to (V _{CC} + 0.3V)
CMOS/TTL Ouput Voltage	-0.3 to (V _{CC} + 0.3V)
LVDS Receiver Input Voltage	-0.3 to (V _{CC} + 0.3V)
LVDS Driver Output Voltage	-0.3 to (V _{CC} + 0.3V)
LVDS Output Short Circuit Duration	continuous
Junction Temperature	+150°C
Storage Temperature Range	-65 to +150°C
Lead Temperature (Soldering, 4 sec.)	+260°C
Maximum Power Dissipation @ +25°C	
DGG0048A (TSSOP) Package:	
DS90CF561	1.98W
DS90CF562	1.89W
Package Derating:	
DS90CF561	16 mW/°C above +25°C
DS90CF562	15 mW/°C above +25°C
This device does not meet 2000V ESD rating ⁽⁴⁾ .	

If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications. (1) "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be verified. They are not meant to imply (2)

that the device should be operated at these limits. The "Electrical Characteristics" specify conditions for device operation. Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground (3)

unless otherwise specified (except V_{OD} and Δ V_{OD}). ESD Rating: HBM (1.5 k Ω , 100 pF) PLL V _{CC} ≥ 1000V

EIAJ (0Ω, 200 pF) ≥ 150V All other pins ≥ 2000V (4)

Recommended Operating Conditions

	Min	Nom	Max	Units
Supply Voltage (V _{CC})	4.5	5.0	5.5	V
Operating Free Air Temperature (T _A)	-10	+25	+70	°C
Receiver Input Range	0		2.4	V
Supply Noise Voltage (V _{CC})			100	mV _{P-P}

Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ ⁽¹⁾	Max	Units
CMOS/TT	L DC SPECIFICATIONS		•			+
V _{IH}	High Level Input Voltage		2.0		V _{CC}	V
V _{IL}	Low Level Input Voltage		GND		0.8	V
V _{OH}	High Level Output Voltage	$I_{OH} = -0.4 \text{ mA}$	3.8	4.9		V
V _{OL}	Low Level Output Voltage	I _{OL} = 2 mA		0.1	0.3	V
V _{CL}	Input Clamp Voltage	I _{CL} = −18 mA		-0.79	-1.5	V
I _{IN}	Input Current	$V_{IN} = V_{CC}$, GND, 2.5V or 0.4V		±5.1	±10	μA
I _{OS}	Output Short Circuit Current	V _{OUT} = 0V			-120	mA

(1) Typical values are given for V_{CC} = 5.0V and T_A = +25°C.



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Electrical Characteristics (continued)

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter	Conditions		Min	Typ ⁽¹⁾	Max	Units
LVDS DR	RIVER DC SPECIFICATIONS						
V _{OD}	Differential Output Voltage	R _L = 100Ω		250	290	450	mV
ΔV_{OD}	Change in V _{OD} between					35	mV
	Complimentary Output States						
V _{CM}	Common Mode Voltage			1.1	1.25	1.375	V
ΔV_{CM}	Change in V _{CM} between					35	mV
	Complimentary Output States						
V _{OH}	High Level Output Voltage				1.3	1.6	V
V _{OL}	Low Level Output Voltage			0.9	1.01		V
los	Output Short Circuit Current	$V_{OUT} = 0V, R_L = 100\Omega$			-2.9	-5	mA
loz	Output TRI-STATE®™ Current	Power Down = $0V$, $V_{OUT} = 0V$ or V_{CC}			±1	±10	μA
LVDS RE	CEIVER DC SPECIFICATIONS			ł	ι – Ι		
V _{TH}	Differential Input High Threshold	V _{CM} = +1.2V				+100	mV
V _{TL}	Differential Input Low Threshold			-100			mV
Input Current	Input Current	V _{IN} = +2.4V	$V_{CC} = 5.5V$			±10	μA
		$V_{IN} = 0V$				±10	μA
TRANSM	ITTER SUPPLY CURRENT			-	• • •		+
I _{CCTW}	Transmitter Supply Current,	$R_{L} = 100\Omega, C_{L} = 5 \text{ pF},$	f = 32.5 MHz		34	51	mA
	Worst Case	Worst Case Pattern (See Figure 6, Figure 8)	f = 37.5 MHz		36	53	mA
I _{CCTG}	Transmitter Supply Current,	$R_{L} = 100\Omega, C_{L} = 5 \text{ pF},$	f = 32.5 MHz		27	47	mA
	16 Grayscale	Grayscale Pattern (See Figure 7, Figure 8)	f = 37.5 MHz		28	48	mA
I _{CCTZ}	Transmitter Supply Current, Power Down	Power Down = Low			1	25	μΑ
RECEIVE	R SUPPLY CURRENT						
I _{CCRW}	Receiver Supply Current,	C _L = 8 pF,	f = 32.5 MHz		55	75	mA
	Worst Case	Worst Case Pattern (See Figure 6, Figure 9)	f = 37.5 MHz		60	80	mA
I _{CCRG}	Receiver Supply Current,	C _L = 8 pF,	f = 32.5 MHz		35	55	mA
		16 Grayscale Pattern See (Figure 7, Figure 9)	f = 37.5 MHz		37	58	mA
I _{CCRZ}	Receiver Supply Current, Power Down	Power Down = Low			1	10	μA

Transmitter Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter	Min	Тур	Max	Units
LLHT	LVDS Low-to-High Transition Time (Figure 8)		0.75	1.5	ns
LHLT	LVDS High-to-Low Transition Time (Figure 8)		0.75	1.5	ns
TCIT	TxCLK IN Transition Time (Figure 10)			8	ns
TCCS	TxOUT Channel-to-Channel Skew ⁽¹⁾ (Figure 11)			350	ps



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Transmitter Switching Characteristics (continued)

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter		Min	Тур	Max	Units
TPPos0	Transmitter Output Pulse Position for Bit 0 (Figure 22)	f = 20 MHz	-200	150	350	ps
TPPos1	Transmitter Output Pulse Position for Bit 1		6.3	7.2	7.5	ns
TPPos2	Transmitter Output Pulse Position for Bit 2		12.8	13.6	14.6	ns
TPPos3	Transmitter Output Pulse Position for Bit 3		20	20.8	21.5	ns
TPPos4	Transmitter Output Pulse Position for Bit 4		27.2	28	28.5	ns
TPPos5	Transmitter Output Pulse Position for Bit 5		34.5	35.2	35.6	ns
TPPos6	Transmitter Output Pulse Position for Bit 6		42.2	42.6	42.9	ns
TPPos0	Transmitter Output Pulse Position for Bit 0 (Figure 21)	f = 40 MHz	-100	100	300	ps
TPPos1	Transmitter Output Pulse Position for Bit 1		2.9	3.3	3.9	ns
TPPos2	Transmitter Output Pulse Position for Bit 2	6.1	6.6	7.1	ns	
TPPos3	Transmitter Output Pulse Position for Bit 3	9.7	10.2	10.7	ns	
TPPos4	Transmitter Output Pulse Position for Bit 4	13	13.5	14.1	ns	
TPPos5	Transmitter Output Pulse Position for Bit 5	17	17.4	17.8	ns	
TPPos6	Transmitter Output Pulse Position for Bit 6	20.3	20.8	21.4	ns	
TCIP	TxCLK IN Period (Figure 12)		25	Т	50	ns
TCIH	TxCLK IN High Time (Figure 12)		0.35T	0.5T	0.65T	ns
TCIL	TxCLK IN Low Time (Figure 12)		0.35T	0.5T	0.65T	ns
TSTC	TxIN Setup to TxCLK IN (Figure 12)	f = 20 MHz	14			ns
			8			ns
THTC	TxIN Hold to TxCLK IN (Figure 12)	2.5	2		ns	
TCCD	TxCLK IN to TxCLK OUT Delay @ 25°C, V _{CC} = 5.0V (Figure 14)	5		9.7	ns	
TPLLS	Transmitter Phase Lock Loop Set (Figure 16)				10	ms
TPDD	Transmitter Powerdown Delay (Figure 20)				100	ns

Receiver Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified

Symbol	Parameter	Min	Тур	Max	Units	
CLHT	CMOS/TTL Low-to-High Transition Time (Figure 9)			3.5	6.5	ns
CHLT	CMOS/TTL High-to-Low Transition Time (Figure 9)			2.7	6.5	ns
RCOP	RxCLK OUT Period (Figure 13)		25	Т	50	ns
RSKM	Receiver Skew Margin ⁽¹⁾ . $V_{CC} = 5V$, $T_A = 25^{\circ}C$ (Figure 23)	f = 20 MHz	1.1			ns
		f = 40 MHz	700			ps
RCOH	RxCLK OUT High Time (Figure 13)	f = 20 MHz	21.5			ns
		f = 40 MHz	10.5			ns
RCOL	RxCLK OUT Low Time (Figure 13)	f = 20 MHz	19			ns
		f = 40 MHz	6			ns
RSRC	RxOUT Setup to RxCLK OUT (Figure 13)	f = 20 MHz	14			ns
		f = 40 MHz	4.5			ns
RHRC	RxOUT Hold to RxCLK OUT (Figure 13)	f = 20 MHz	16			ns
		f = 40 MHz	6.5			ns
RCCD	RxCLK IN to RxCLK OUT Delay @ 25°C, V _{CC} = 5.0V (Figure 15)				11.9	ns
RPLLS	Receiver Phase Lock Loop Set (Figure 17)			10	ms	
RPDD	Receiver Powerdown Delay (Figure 21)				1	μs

(1) Receiver Skew Margin is defined as the valid data sampling region at the receiver inputs. This margin takes into account for transmitter output skew(TCCS) and the setup and hold time (internal data sampling window), allowing LVDS cable skew dependent on type/length and source clock(TxCLK IN) jitter. RSKM ≥ cable skew (type, length) + source clock jitter (cycle to cycle).

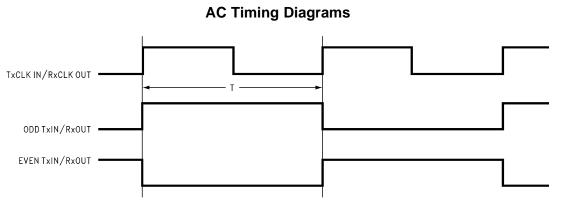
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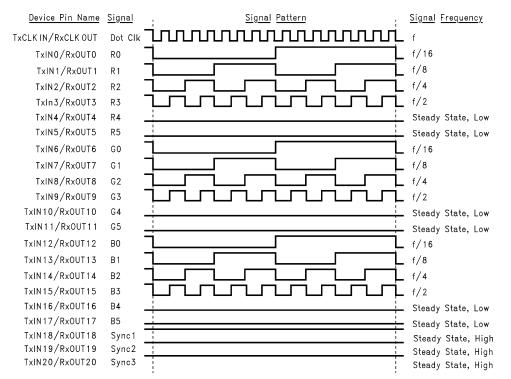
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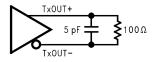
The worst case test pattern produces a maximum toggling of device digital circuitry, LVDS I/O and TTL I/O.

The 16 grayscale test pattern tests device power consumption for a "typical" LCD display pattern. The test pattern approximates signal switching needed to produce groups of 16 vertical stripes across the display.

Figure 6 and Figure 7 show a falling edge data strobe (TxCLK IN/RxCLK OUT).

Recommended pin to signal mapping. Customer may choose to define differently.

Figure 7. "16 Grayscale" Test Pattern



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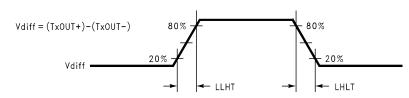


Figure 8. DS90CF561 (Transmitter) LVDS Output Load and Transition Timing

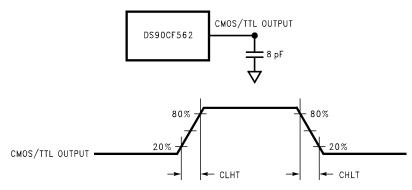


Figure 9. DS90CF562 (Receiver) CMOS/TTL Output Load and Transition Timing

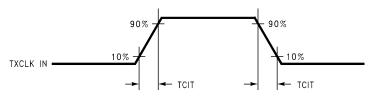
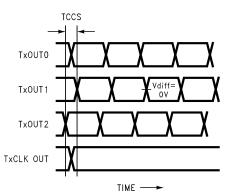


Figure 10. DS90CF561 (Transmitter) Input Clock Transition Time



Measurements at Vdiff = 0V TCCS measured between earliest and latest initial LVDS edges. TxCLK OUT Differential High \rightarrow Low Edge for DS90CF561 TxCLK OUT Differential Low \rightarrow High Edge for DS90CR561

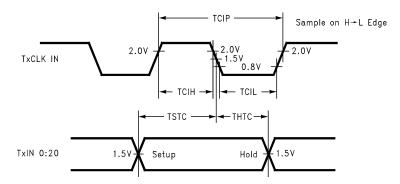
Figure 11. DS90CF561 (Transmitter) Channel-to-Channel Skew and Pulse Width

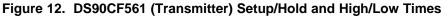
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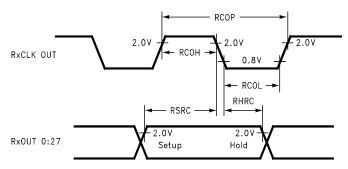


Figure 13. DS90CF562 (Receiver) Setup/Hold and High/Low Times

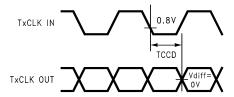


Figure 14. DS90CF561 (Transmitter) Clock In to Clock Out Delay

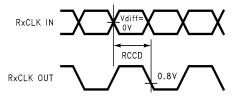


Figure 15. DS90CF562 (Receiver) Clock In to Clock Out Delay

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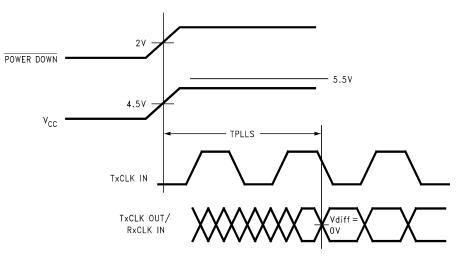


Figure 16. DS90CF561 (Transmitter) Phase Lock Loop Set Time

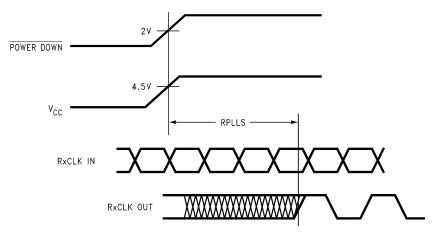


Figure 17. DS90CF562 (Receiver) Phase Lock Loop Set Time

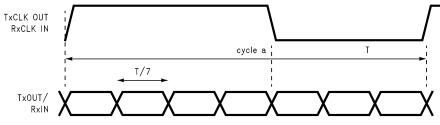
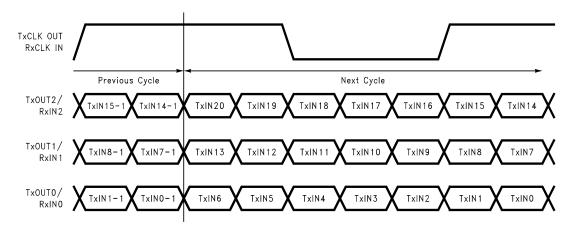


Figure 18. Seven Bits of LVDS in One Clock Cycle

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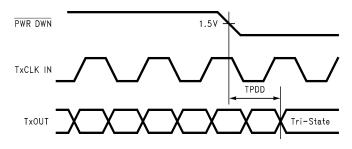


Figure 20. Transmitter Powerdown Delay

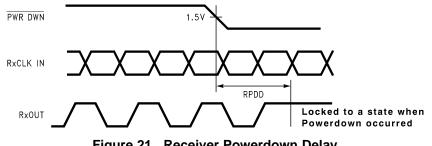
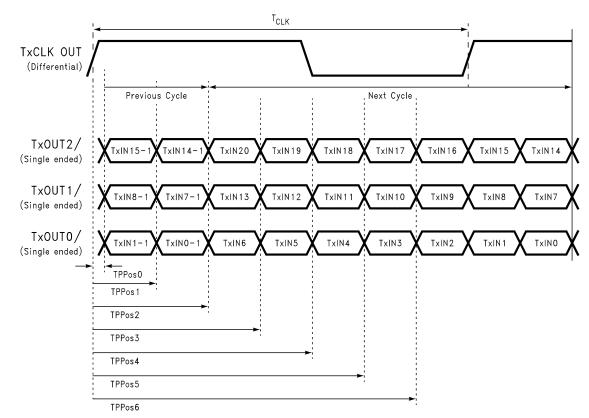


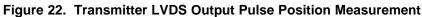
Figure 21. Receiver Powerdown Delay

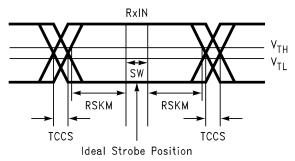




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SW—Setup and Hold Time (Internal Data Sampling Window) TCCS—Transmitter Output Skew RSKM ≥ Cable Skew (Type, Length) + Source Clock Jitter (Cycle to Cycle) Cable Skew—Typically 10 ps–40 ps per foot



Pin Name	I/O	No.	Description
TxIN	I	21	TTL level input. This includes: 6 Red, 6 Green, 6 Blue, and 3 control lines (FPLINE, FPFRAME, DRDY). (Also referred to as HSYNC, VSYNC and DATA ENABLE.)
TxOUT+	0	3	Positive LVDS differential data output
TxOUT-	0	3	Negative LVDS differential data output
FPSHIFT IN	I	1	TTL level clock input. The falling edge acts as data strobe.
TxCLK OUT+	0	1	Positive LVDS differential clock output
TxCLK OUT-	0	1	Negative LVDS differential clock output

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DS90CF561 PIN DESCRIPTION—FPD LINK TRANSMITTER (continued)

Pin Name	I/O	No.	Description
PWR DOWN	I	1	TTL level input. Assertion (low input) TRI-STATES the outputs, ensuring low current at power down.
V _{CC}	I	4	Power supply pins for TTL inputs
GND	I	5	Ground pins for TTL inputs
PLL V _{CC}	I	1	Power supply pin for PLL
PLL GND	I	2	Ground pins for PLL
LVDS V _{CC}	I	1	Power supply pin for LVDS outputs
LVDS GND	I	3	Ground pins for LVDS outputs

DS90CF562 PIN DESCRIPTION—FPD LINK RECEIVER

Pin Name	I/O	No.	Description	
RxIN+	I	3	Positive LVDS differential data inputs	
RxIN-	Ι	3	Negative LVDS differential data inputs	
RxOUT	0	21	TTL level data outputs. This includes: 6 Red, 6 Green, 6 Blue, and 3 control lines (FPLINE, FPFRAME, DRDY). (Also referred to as HSYNC, VSYNC and DATA ENABLE.)	
RxCLK IN+	I	1	Positive LVDS differential clock input	
RxCLK IN-	I	1	Negative LVDS differential clock input	
FPSHIFT OUT	0	1	TTL level clock output. The falling edge acts as data strobe.	
PWR DOWN	I	1	TTL level input. Assertion (low input) maintains the receiver outputs in the previous state	
V _{CC}	I	4	Power supply pins for TTL outputs	
GND	I	5	Ground pins for TTL outputs	
PLL V _{CC}	I	1	Power supply for PLL	
PLL GND	I	2	Ground pin for PLL	
LVDS V _{CC}	I	1	Power supply pin for LVDS inputs	
LVDS GND	Ι	3	Ground pins for LVDS inputs	



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•	Changed layout of National Data Sheet to TI format	12	
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